Characterization of a core-shell MOF (UiO-66(Zr)@SiO₂) by depth profiling experiments using an aerosol time-of-flight mass spectrometer

John F. Cahill,a Honghan Fei,a Seth M. Cohen,a Kimberly A. Prathera,b

aDepartment of Chemistry and Biochemistry, University of California, La Jolla, California, 920372
bScripps Institution of Oceanography, University of California, La Jolla, California, 92093
Fig. S1. TEM images of ZrO$_2$@SiO$_2$ (top) and SiO$_2$@ZrO$_2$ (bottom).